Search Notes		

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/717,265	KIM ET AL.	
Examiner	Art Unit	
David C. Payne	2613	

SEARCHED			
Class	Subclass	Date	Examiner
398	187, 197	9/16/2006	DCP
359	276, 278	9/16/2006	DCP
250	214R	9/16/2006	DCP
	* * * * * * * *	· · · · · · · · · · · · · · · · · · ·	
			-

INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	

SEARCH NO (INCLUDING SEARCI)
	DATE	EXMR
EAST as shown	9/16/2006	DCP